PTO/SB/08 Equivalent

·	Application No.	10/810,660
INFORMATION DISCLOSURE	Filing Date	March 29, 2004
STATEMENT BY APPLICANT	First Named Inventor	Wen-Jian Lin
STATEMENT BY APPLICANT	Art Unit	2823
(Multiple sheets used when necessary)	Examiner	Jarrett J. Stark
SHEET 4 OF 6	Attorney Docket No.	QCO.091A/061121

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Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
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Examiner Signature Jath Hate Date Considered 10/11/2006

KRH 7-13-7

^{*}Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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SHEET 2 OF 6	Attorney Docket No.	QCO.091A/061121

U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	
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STATEMENT BY APPLICANT	Art Unit	2823
(Multiple sheets used when necessary)	Examiner	Jarrett J. Stark
SHEET 3 OF 15	Attorney Docket No.	QCO.091A

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Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
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